SN54284, SN54285, SN74284, SN74285
4-BIT BY 4-BIT PARALLEL BINARY MULTIPLIERS

MAY 1972 – REVISED MARCH 1988

- Fast Multiplication of Two Binary Numbers 8-Bit Product in 40 ns Typical
- Expandable for N-Bit-by-n-Bit Applications: 16-Bit Product in 70 ns Typical 32-Bit Product in 103 ns Typical
- Fully Compatible with Most TTL Circuits
- Diode-Clamped Inputs Simplify System Design

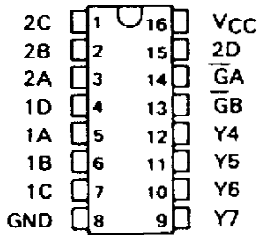
description

These high-speed TTL circuits are designed to be used in high-performance parallel multiplication applications. When connected as shown in Figure A, these circuits perform the positive-logic multiplication of two 4-bit binary words. The eight-bit binary product is generated with typically only 40 nanoseconds delay.

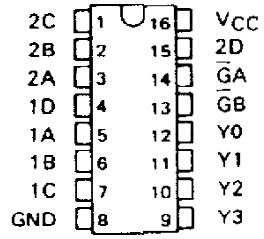
This basic four-by-four multiplier can be utilized as a fundamental building block for implementing larger multipliers. For example, the four-by-four building blocks can be connected as shown in Figure B to generate submultiple partial products. These results can then be summed in a Wallace tree, and, as illustrated, will produce a 16-bit product for the two eight-bit words typically in 70 nanoseconds. SN54H183/SN74H183 carry-save adders and SN54S181/SN74S181 arithmetic logic units with the SN54S182/SN74S182 look-ahead generator are used to achieve this high performance. The scheme is expandable for implementing N X M bit multipliers.

The SN54284 and SN54285 are characterized for operation over the full military temperature range of −55°C to 125°C; the SN74284 and SN74285 are characterized for operation from 0°C to 70°C.

SN54284 . . . J OR W PACKAGE
SN74284 . . . N PACKAGE
(TOP VIEW)

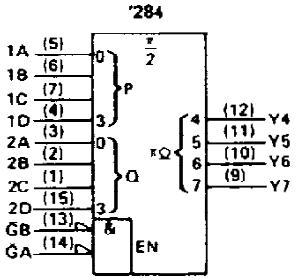


SN54285 . . . J OR W PACKAGE
SN74285 . . . N PACKAGE
(TOP VIEW)

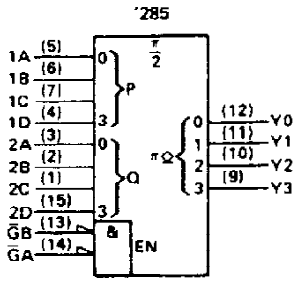


logic symbols†

'284



'285

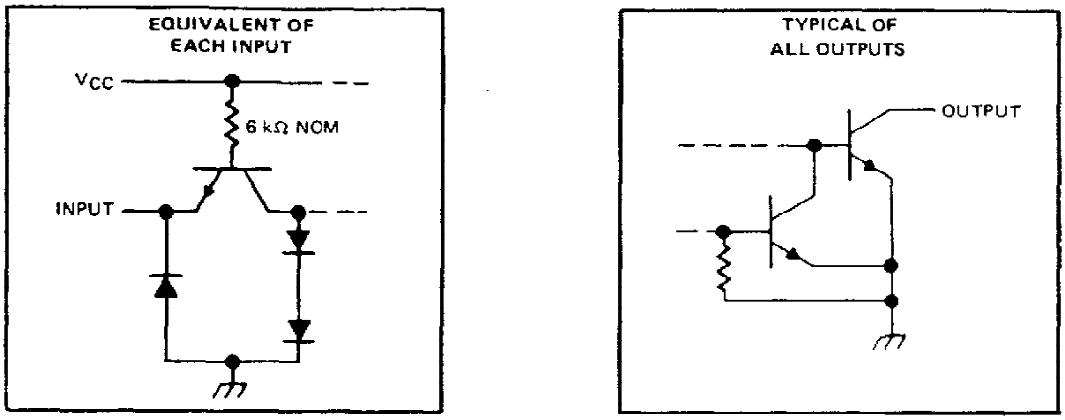


†These symbols are in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

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schematics



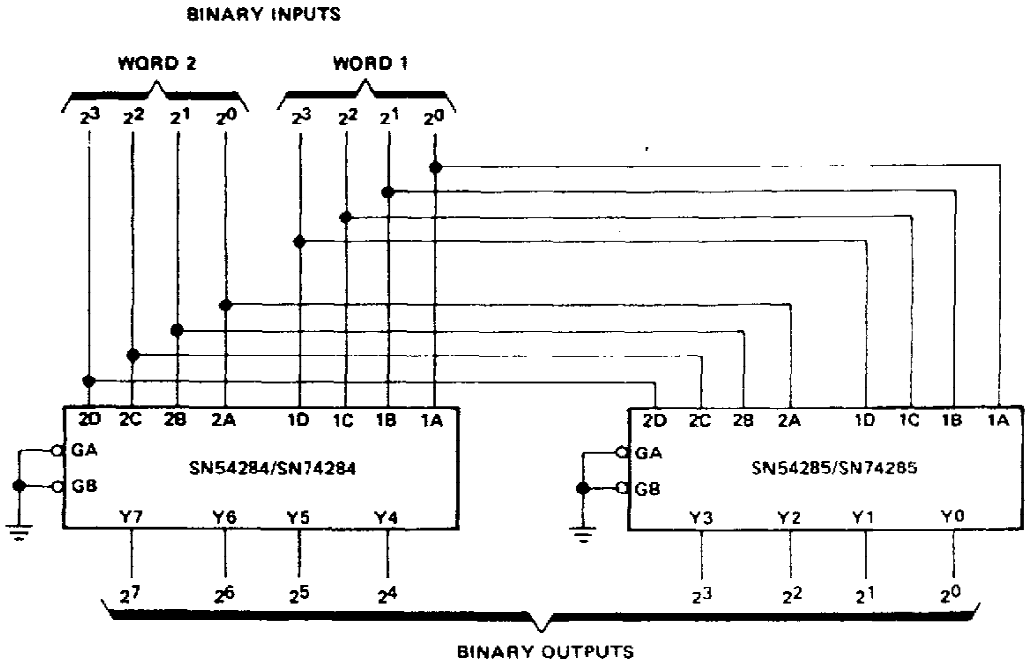


FIGURE A–4 X 4 MULTIPLIER

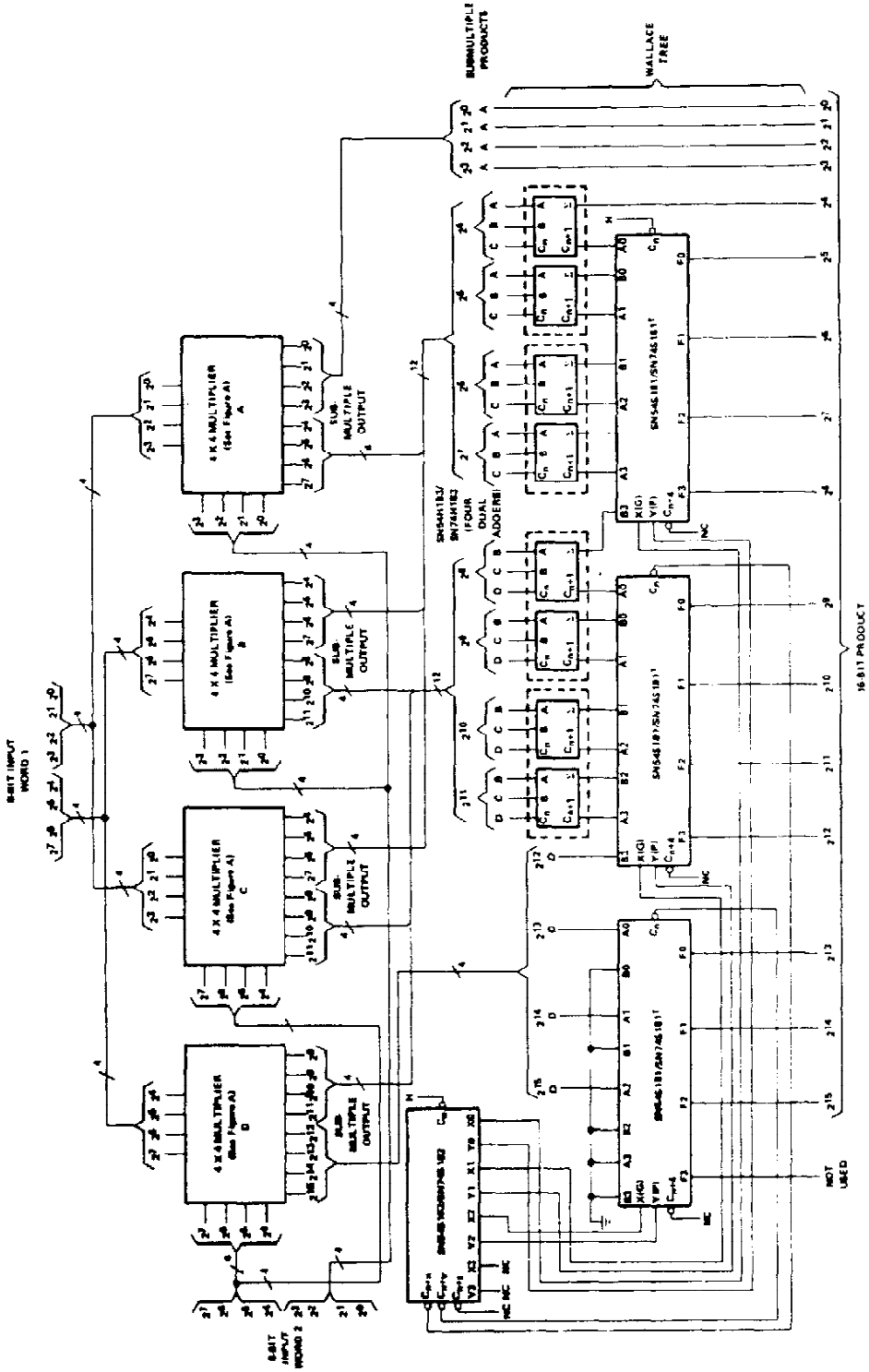


FIGURE B–8 X 8 MULTIPLIER

†Other terminals of the three SN54S181/SN74S181 ALU's are connected as follows: S3 = H, S2 = L, S1 = L, S0 = H, M = L. Output A = B is not used for this application.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage . . . . . 5.5 V
Operating free-air temperature range: SN54' Circuits . . . . . −55°C to 125°C
SN74' Circuits . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

	SN54284 SN54285			SN74284 SN74285			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, V_{CC}	4.5	5	5.5	4.75	5	5.25	V
High-level output voltage, V_{OH}			5.5			5.5	V
Low-level output current, I_{OL}			16			16	mA
Operating free-air temperature, T_A	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		MIN	TYP‡	MAX	UNIT
V_{IH}	High-level input voltage			2			V
V_{IL}	Low-level input voltage					0.8	V
V_I	Input clamp voltage	V_{CC} = MIN,	I_I = −12 mA			−1.5	V
I_{OH}	High-level output current	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V,	V_{OH} = 5.5 V			40	μA
V_{OL}	Low-level output voltage	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V	I_{OL} = 12 mA			0.4	V
			I_{OL} = 16 mA			0.45	
I_I	Input current at maximum input voltage	V_{CC} = MAX,	V_I = 5.5 V			1	mA
I_{IH}	High-level input current	V_{CC} = MAX,	V_I = 2.4 V			40	μA
I_{IL}	Low-level input current	V_{CC} = MAX,	V_I = 0.4 V			−1	mA
I_{CC}	Supply current	V_{CC} = MAX, T_A = 125°C, See Note 2	SN54284, SN54285 N package only			99	mA
		V_{CC} = MAX, See Note 2	SN54284, SN54285		92	110	
			SN74284, SN74285		92	130	

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.
‡All typical values are at V_{CC} = 5 V, T_A = 25°C.
NOTE 2: With outputs open and both enable inputs grounded, I_{CC} is measured first by selecting an output product which contains three or more high-level bits, then by selecting an output product which contains four low-level bits.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	Propagation delay time, low-to-high-level output from enable	C_L = 30 pF to GND, R_{L1} = 300 Ω to V_{CC}, R_{L2} = 600 Ω to GND, See Note 3		20	30	ns
t_{PHL}	Propagation delay time, high-to-low-level output from enable			20	30	
t_{PLH}	Propagation delay time, low-to-high-level output from word inputs			40	60	ns
t_{PHL}	Propagation delay time, high-to-low-level output from word inputs			40	60	

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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